

Notice of References Cited	Application/Control No. 10/659,593		Applicant(s)/Patent Under Reexamination LEE, BAEK-WOON	
	Examiner Stephen G. Sherman		Art Unit 2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,164,403	01-2007	Isami et al.	345/89
*	B	US-6,985,194	01-2006	Kawano et al.	349/54
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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